

# Silicon Carbide (SiC) MOSFET – 80 mohm, 1200 V, M1, D2PAK-7L

# NTBG080N120SC1

#### **Features**

- Typ.  $R_{DS(on)} = 80 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>G(tot)</sub> = 56 nC)
- Low Effective Output Capacitance (Typ. Coss = 79 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Typical Applications**

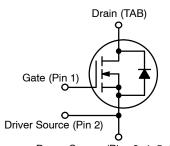
- UPS
- DC-DC Converter
- Boost Inverter

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter  |                                     | Symbol                            | Value          | Unit    |   |
|--|-------------------------------------|-----------------------------------|----------------|---------|---|
| Drain-to-Source Voltage  |                                     | $V_{DSS}$                         | 1200           | V       |   |
| Gate-to-Source Voltage   | ge                                  |                                   | $V_{GS}$       | -15/+25 | V |
| Recommended Operation<br>Values of Gate-Source Voltage                                       |                                     | T <sub>C</sub> < 175°C            | $V_{GSop}$     | -5/+20  | ٧ |
| Continuous Drain<br>Current (Note 1)   | Steady<br>State                     | T <sub>C</sub> = 25°C             | I <sub>D</sub> | 30      | Α |
| Power Dissipation (Note 1)   |                                     |                                   | P <sub>D</sub> | 179     | W |
| Continuous Drain<br>Current (Note 1)   | Steady State T <sub>C</sub> = 100°C |                                   | I <sub>D</sub> | 21      | Α |
| Power Dissipation (Note 1)   |                                     |                                   | P <sub>D</sub> | 89      | W |
| Pulsed Drain Current (Note 2) T <sub>C</sub> = 25°C  |                                     | I <sub>DM</sub>                   | 110            | Α       |   |
| Operating Junction and Storage Temperature Range   |                                     | T <sub>J</sub> , T <sub>stg</sub> | -55 to<br>+175 | °C      |   |
| Source Current (Body Diode)  |                                     | I <sub>S</sub>                    | 18             | Α       |   |
| Single Pulse Drain-to-Source Avalanche Energy ( $I_L$ = 18.5 $A_{pk}$ , $L$ = 1 mH) (Note 3) |                                     | E <sub>AS</sub>                   | 171            | mJ      |   |
| Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds                        |                                     | TL                                | 300            | °C      |   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 1200 V               | 110 mΩ @ 20 V           | 30 A               |



Power Source (Pins 3, 4, 5, 6, 7)

#### **N-CHANNEL MOSFET**



D2PAK-7L CASE 418BJ

#### MARKING DIAGRAM

AYWWZZ NTBG 080120SC1

A = Assembly Location

Y - Year

Y = Year WW = Work Week ZZ = Lot Traceability

NTBG080120SC1 = Specific Device Code

#### **ORDERING INFORMATION**

| Device         | Package  | Shipping <sup>†</sup> |
|----------------|----------|-----------------------|
| NTBG080N120SC1 | D2PAK-7L | 800 /<br>Tape & Reel  |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

<sup>2.</sup> Repetitive rating, limited by max junction temperature.

3.  $E_{AS}$  of 171 mJ is based on starting  $T_J$  = 25°C; L = 1 mH,  $I_{AS}$  = 18.5 A,  $V_{DD}$  = 120 V,  $V_{GS}$  = 18 V.

# **Table 1. THERMAL CHARACTERISTICS**

| Parameter                                       | Symbol         | Max  | Unit |
|---|----------------|------|------|
| Thermal Resistance Junction-to-Case (Note 1)    | $R_{	heta JC}$ | 0.84 | °C/W |
| Thermal Resistance Junction-to-Ambient (Note 1) | $R_{	hetaJA}$  | 40   | °C/W |

# Table 2. ELECTRICAL CHARACTERISTICS (T $_J$ = 25 $^{\circ}$ C unless otherwise stated)

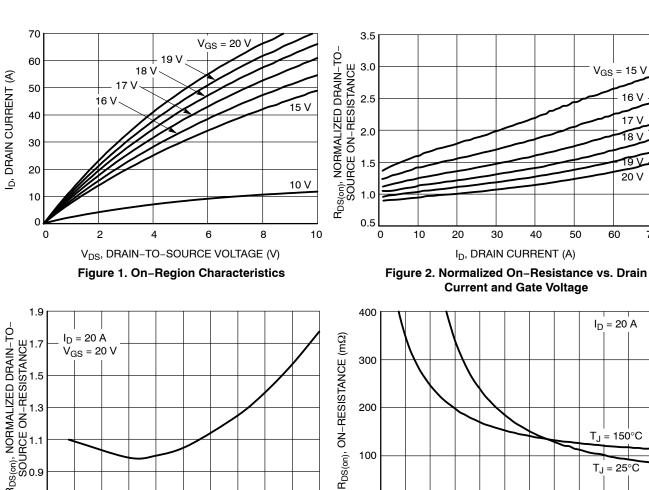
| Parameter  | Symbol                               | Test Condition  | Min  | Тур  | Max | Unit |
|--|--------------------------------------|---|------|------|-----|------|
| OFF CHARACTERISTICS  |                                      |   | •    |      |     |      |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                 | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA                          | 1200 |      |     | V    |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> | I <sub>D</sub> = 1 mA, refer to 25°C                                  |      | 0.5  |     | V/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                     | $V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$             |      |      | 100 | μΑ   |
|  |                                      | V <sub>DS</sub> = 1200 V T <sub>J</sub> = 175°C                       |      |      | 1   | mA   |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                     | V <sub>GS</sub> = +25/-15 V, V <sub>DS</sub> = 0 V                    |      |      | ±1  | μΑ   |
| ON CHARACTERISTICS (Note 2)                                  |                                      |   |      |      |     |      |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                  | $V_{GS} = V_{DS}$ , $I_D = 5 \text{ mA}$                              | 1.8  | 3    | 4.3 | V    |
| Recommended Gate Voltage                                     | $V_{GOP}$                            |   | -5   |      | +20 | V    |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 25°C  |      | 80   | 110 | mΩ   |
|  |                                      | V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 150°C |      | 121  |     | mΩ   |
| Forward Transconductance                                     | 9FS                                  | V <sub>DS</sub> = 20 V, I <sub>D</sub> = 20 A                         |      | 11   |     | S    |
| CHARGES, CAPACITANCES & GATE RES                             | ISTANCE                              |   |      |      |     |      |
| Input Capacitance  | C <sub>ISS</sub>                     | V <sub>GS</sub> = 0 V, f = 1 MHz,                                     |      | 1154 |     | pF   |
| Output Capacitance   | C <sub>OSS</sub>                     | V <sub>DS</sub> = 800 V   |      | 79   |     |      |
| Reverse Transfer Capacitance                                 | C <sub>RSS</sub>                     |   |      | 7.9  |     |      |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  | $V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V},$                   |      | 56   |     | nC   |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   | I <sub>D</sub> = 20 A   |      | 10   |     |      |
| Gate-to-Source Charge  | $Q_{GS}$                             |   |      | 18   |     |      |
| Gate-to-Drain Charge   | $Q_{GD}$                             |   |      | 11   |     |      |
| Gate-Resistance  | $R_{G}$                              | f = 1 MHz   |      | 1.2  |     | Ω    |
| SWITCHING CHARACTERISTICS                                    |                                      |   |      | 1    |     |      |
| Turn-On Delay Time   | t <sub>d(ON)</sub>                   | $V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$                   |      | 12   | 22  | ns   |
| Rise Time  | t <sub>r</sub>                       | $I_D$ = 20 A, $R_G$ = 4.7 $\Omega$ , Inductive Load                   |      | 12   | 22  |      |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>                  |   |      | 21   | 34  |      |
| Fall Time  | t <sub>f</sub>                       |   |      | 9    | 18  | 1    |
| Turn-On Switching Loss                                       | E <sub>ON</sub>                      |   |      | 135  |     | μJ   |
| Turn-Off Switching Loss                                      | E <sub>OFF</sub>                     |   |      | 46   |     |      |
| Total Switching Loss   | E <sub>TOT</sub>                     |   |      | 181  |     |      |
| DRAIN-SOURCE DIODE CHARACTERIST                              | ics                                  |   | •    |      |     |      |
| Continuous Drain-Source Diode Forward Current                | I <sub>SD</sub>                      | V <sub>GS</sub> = -5 V, T <sub>J</sub> = 25°C                         |      |      | 18  | Α    |
| Pulsed Drain-Source Diode Forward<br>Current (Note 2)        | I <sub>SDM</sub>                     | V <sub>GS</sub> = -5 V, T <sub>J</sub> = 25°C                         |      |      | 110 | Α    |
| Forward Diode Voltage  | $V_{SD}$                             | V <sub>GS</sub> = −5 V, I <sub>SD</sub> = 10 A, T <sub>J</sub> = 25°C |      | 3.9  |     | V    |

Table 2. ELECTRICAL CHARACTERISTICS (T<sub>.1</sub> = 25°C unless otherwise stated) (continued)

|                                  | 1100 (.) =0      | o amoso omisimos otatoa) (osimiasa                 | ,   |      |     |      |
|----------------------------------|------------------|--|-----|------|-----|------|
| Parameter                        | Symbol           | Test Condition                                     | Min | Тур  | Max | Unit |
| DRAIN-SOURCE DIODE CHARACTERISTI | cs               |  |     |      |     |      |
| Reverse Recovery Time            | t <sub>RR</sub>  | $V_{GS} = -5/20 \text{ V}, I_{SD} = 20 \text{ A},$ |     | 16.2 |     | ns   |
| Reverse Recovery Charge          | Q <sub>RR</sub>  | dl <sub>S</sub> /dt = 1000 A/μs                    |     | 61.6 |     | nC   |
| Reverse Recovery Energy          | E <sub>REC</sub> |  |     | 4.1  |     | μJ   |
| Peak Reverse Recovery Current    | I <sub>RRM</sub> |  |     | 7.6  |     | Α    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### TYPICAL CHARACTERISTICS



R<sub>DS(on)</sub>, NORMALIZED DRAIN-TO-SOURCE ON-RESISTANCE 0 T C T 0.7 -50 -25 25 75 100 125 150 -75 0 50 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)



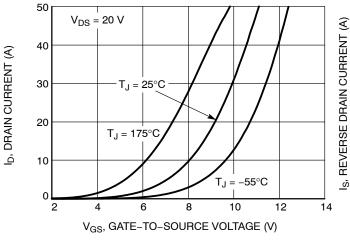
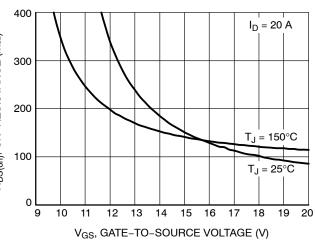


Figure 5. Transfer Characteristics



70

Figure 4. On-Resistance vs. Gate-to-Source Voltage

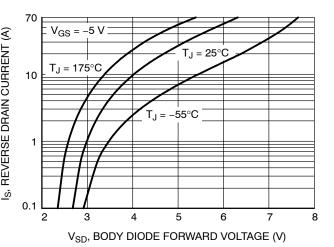


Figure 6. Diode Forward Voltage vs. Current

#### TYPICAL CHARACTERISTICS (continued)

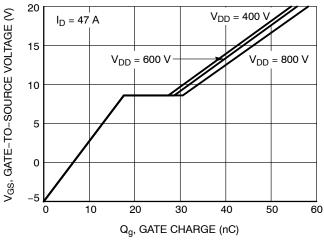


Figure 7. Gate-to-Source Voltage vs. Total Charge

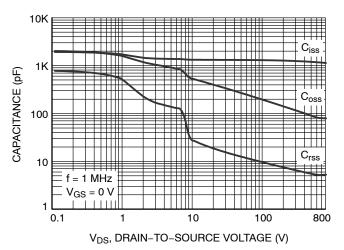


Figure 8. Capacitance vs. Drain-to-Source Voltage

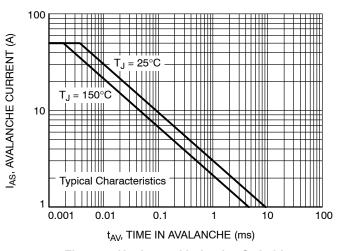


Figure 9. Unclamped Inductive Switching Capability

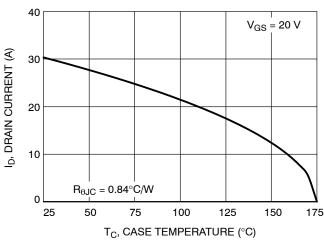


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

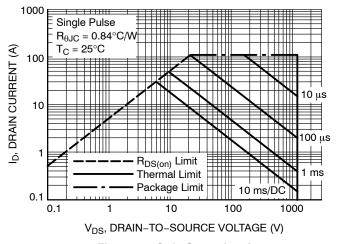


Figure 11. Safe Operating Area

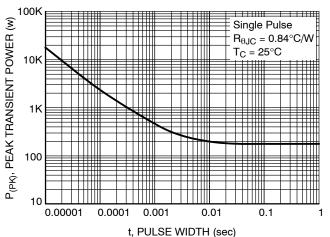


Figure 12. Single Pulse Maximum Power Dissipation

# TYPICAL CHARACTERISTICS (continued)

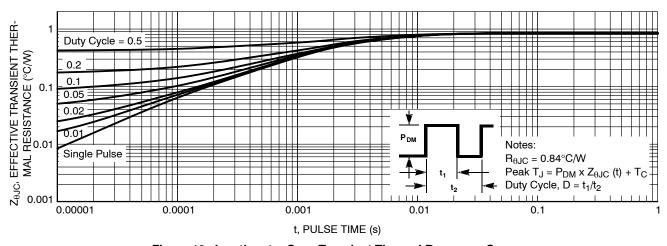


Figure 13. Junction-to-Case Transient Thermal Response Curve

#### D<sup>2</sup>PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**

**DATE 16 AUG 2019** 

#### NOTES:

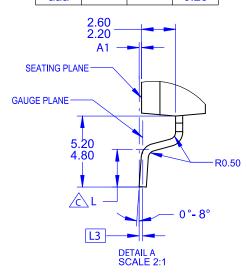
A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.

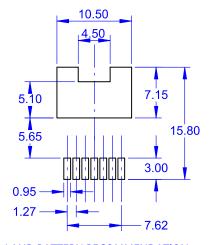
D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

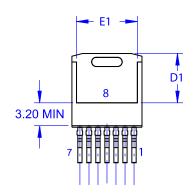
| DIM | MILLIMETERS |       |       |  |
|-----|-------------|-------|-------|--|
| MIN |             | NOM   | MAX   |  |
| Α   | 4.30        | 4.50  | 4.70  |  |
| A1  | 0.00        | 0.10  | 0.20  |  |
| b2  | 0.60        | 0.70  | 0.80  |  |
| b   | 0.51        | 0.60  | 0.70  |  |
| С   | 0.40        | 0.50  | 0.60  |  |
| c2  | 1.20        | 1.30  | 1.40  |  |
| D   | 9.00        | 9.20  | 9.40  |  |
| D1  | 6.15        | 6.80  | 7.15  |  |
| Е   | 9.70        | 9.90  | 10.20 |  |
| E1  | 7.15        | 7.65  | 8.15  |  |
| е   | ~           | 1.27  | ~     |  |
| Н   | 15.10       | 15.40 | 15.70 |  |
| L   | 2.44        | 2.64  | 2.84  |  |
| L1  | 1.00        | 1.20  | 1.40  |  |
| L3  | ~           | 0.25  | ~     |  |
| aaa | ~           | ~     | 0.25  |  |

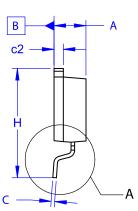


| A        | E L1        |
|----------|-------------|
| D        |             |
| <u> </u> |             |
| b2 —     |             |
| e aaa B  | b —   A   M |



LAND PATTERN RECOMMENDATION





## **GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to

| device data sneet for actual part marking.  |
|---|
| Pb-Free indicator, "G" or microdot "■", may |
| or may not be present. Some products may    |
| not follow the Generic Marking.             |
|   |

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